

Notice of References Cited	Application/Control No. 10/584,213		Applicant(s)/Patent Under Reexamination MARTINEZ ET AL.	
	Examiner Sunray R. Chang		Art Unit 2121	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,268,853	07-2001	Hoskins et al.	700/83
*	B	US-6,421,571	07-2002	Spriggs et al.	700/17
*	C	US-2005/0007249	01-2005	Eryurek et al.	340/511
*	D	US-6,556,950	04-2003	Schwenke et al.	702/183
*	E	US-2003/0028269	02-2003	Spriggs et al.	700/83
*	F	US-2003/0023518	01-2003	Spriggs et al.	705/28
*	G	US-2002/0169514	11-2002	Eryurek et al.	700/110
*	H	US-2002/0163427	11-2002	Eryurek et al.	340/500
*	I	US-2002/0147511	10-2002	Eryurek et al.	700/80
*	J	US-2002/0022894	02-2002	Eryurek et al.	700/80
*	K	US-6,233,566	05-2001	Levine et al.	705/36R
*	L	US-7,272,815	09-2007	Eldridge et al.	717/101
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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